## Application/Control No. Applicant(s)/Patent Under Reexamination 10/708,301 KUIBIRA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3742 Sang Y. Paik **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 219/444.1 10-2003 US-6,639,189 Ramanan et al. Α US-В

## FOREIGN PATENT DOCUMENTS

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